



ALPHA & OMEGA
SEMICONDUCTOR

AOT66616L/AOB66616L

60V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGT™ technology
- Low $R_{DS(ON)}$
- Excellent Gate Charge $\times R_{DS(ON)}$ Product (FOM)
- RoHS and Halogen-Free Compliant

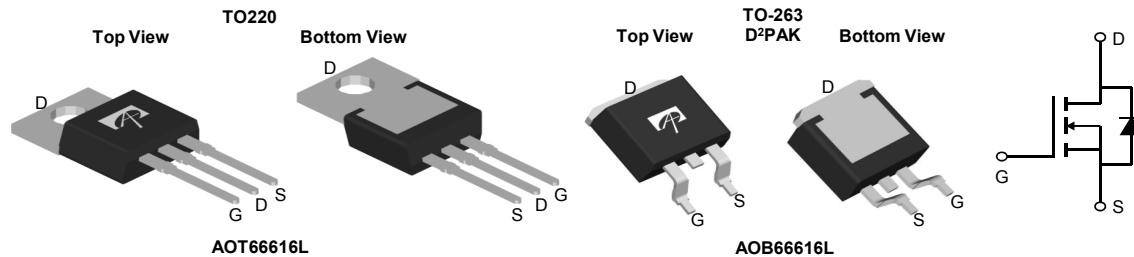
Product Summary

| | |
|---------------------------------|---------|
| V_{DS} | 60V |
| I_D (at $V_{GS}=10V$) | 140A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 3.2mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=6V$) | < 4.6mΩ |

Applications

- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial

100% UIS Tested
100% R_g Tested



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOT66616L | TO-220 | Tube | 1000 |
| AOB66616L | TO-263 | Tape & Reel | 800 |

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|-----------------------------------------|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 60 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^G | I_D | 140 | A |
| $T_C=100^\circ C$ | | 95 | |
| Pulsed Drain Current ^C | I_{DM} | 330 | |
| Continuous Drain Current | I_{DSM} | 38.5 | A |
| $T_A=70^\circ C$ | | 30.5 | |
| Avalanche Current ^C | I_{AS} | 35 | A |
| Avalanche energy $L=0.3mH$ ^C | E_{AS} | 184 | mJ |
| Power Dissipation ^B | P_D | 125 | W |
| $T_C=100^\circ C$ | | 50 | |
| Power Dissipation ^A | P_{DSM} | 8.3 | W |
| $T_A=70^\circ C$ | | 5.3 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|---------------------------------------------------------|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A $t \leq 10s$ | $R_{\theta JA}$ | 12 | 15 | °C/W |
| Maximum Junction-to-Ambient ^{A,D} Steady-State | | 50 | 60 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 0.8 | 1.0 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------|-----|------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 60 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=60\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$ | | | ±100 | nA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 2.4 | 2.9 | 3.4 | V |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | 2.5 | 3.2 | | $\text{m}\Omega$ |
| | | $V_{GS}=6\text{V}, I_D=20\text{A}$ | 4.0 | 5.1 | | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=20\text{A}$ | 100 | | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}, V_{GS}=0\text{V}$ | 0.7 | 1 | | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 135 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=30\text{V}, f=1\text{MHz}$ | | 2870 | | pF |
| C_{oss} | Output Capacitance | | | 940 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 38 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | 0.6 | 1.25 | 1.9 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=30\text{V}, I_D=20\text{A}$ | | 42.5 | 60 | nC |
| Q_{gs} | Gate Source Charge | | | 12 | | nC |
| Q_{gd} | Gate Drain Charge | | | 10 | | nC |
| Q_{oss} | Output Charge | $V_{GS}=0\text{V}, V_{DS}=30\text{V}$ | | 54 | | nC |
| $t_{\text{D(on)}}$ | Turn-On Delay Time | $V_{GS}=10\text{V}, V_{DS}=30\text{V}, R_L=1.5\Omega, R_{\text{GEN}}=3\Omega$ | | 14.5 | | ns |
| t_r | Turn-On Rise Time | | | 15.5 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off Delay Time | | | 33 | | ns |
| t_f | Turn-Off Fall Time | | | 12.5 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}, \text{di}/\text{dt}=500\text{A}/\mu\text{s}$ | | 26 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}, \text{di}/\text{dt}=500\text{A}/\mu\text{s}$ | | 87 | | nC |

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\theta JA} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

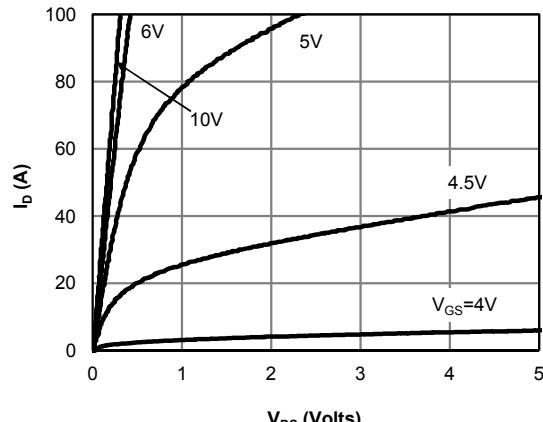
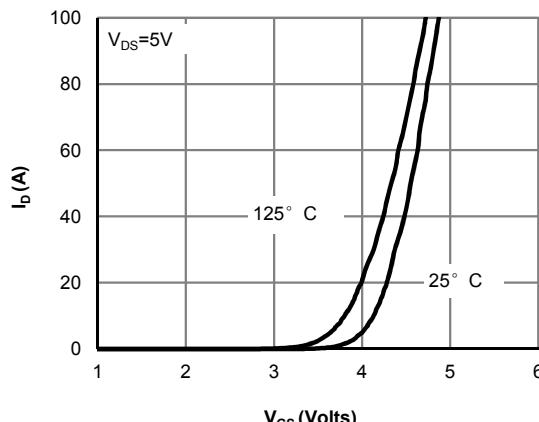
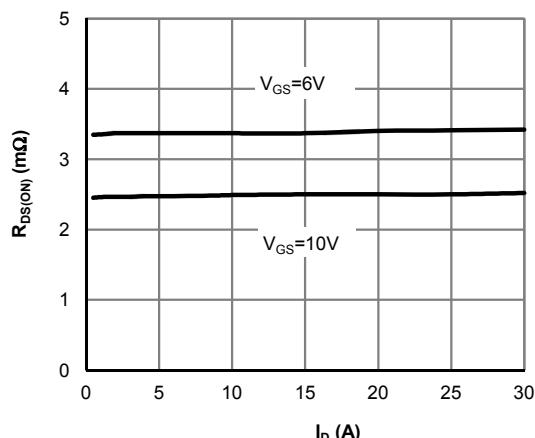
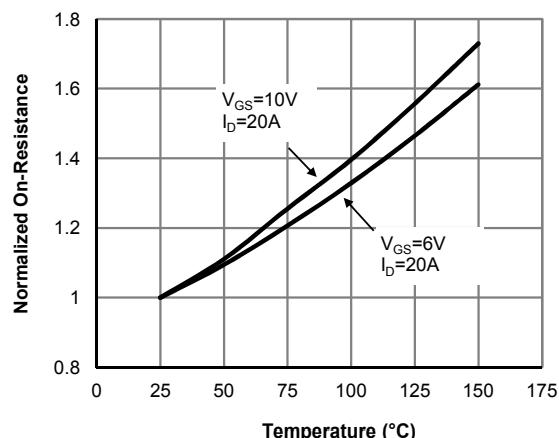
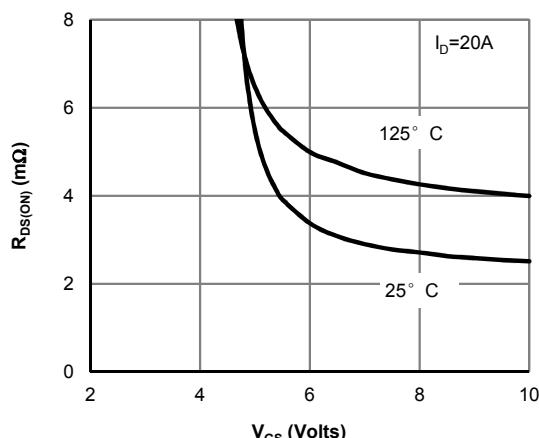
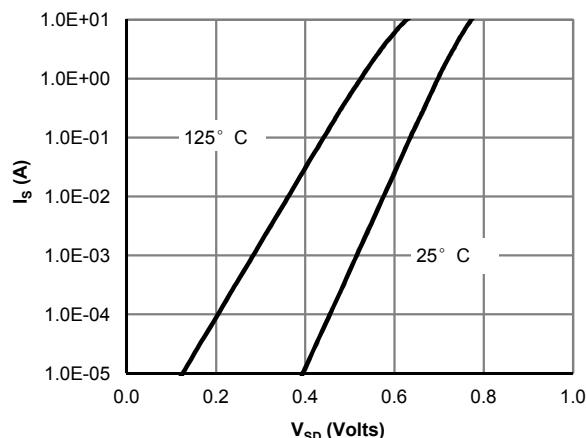
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

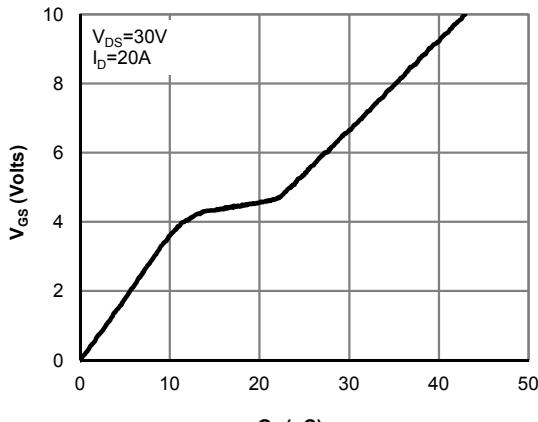


Figure 7: Gate-Charge Characteristics

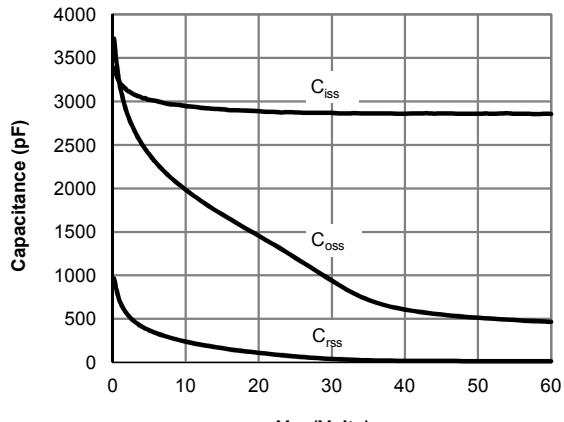


Figure 8: Capacitance Characteristics

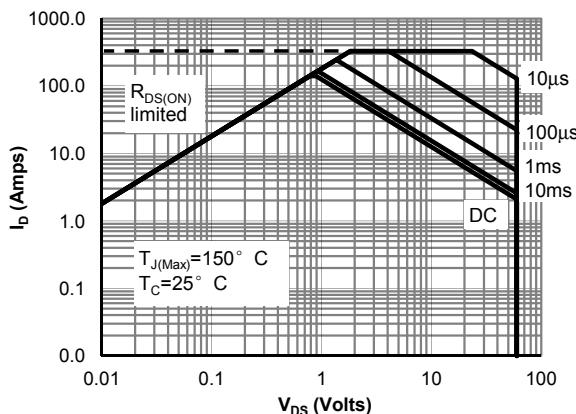


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

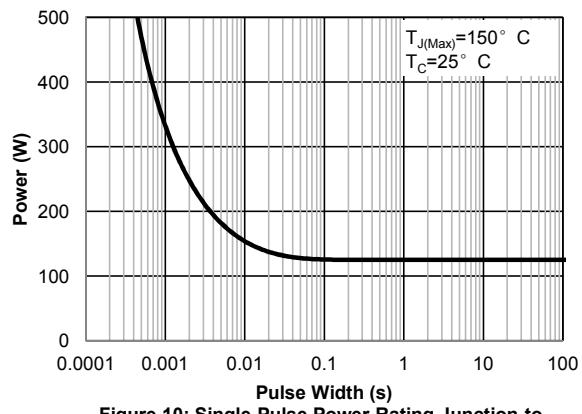


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

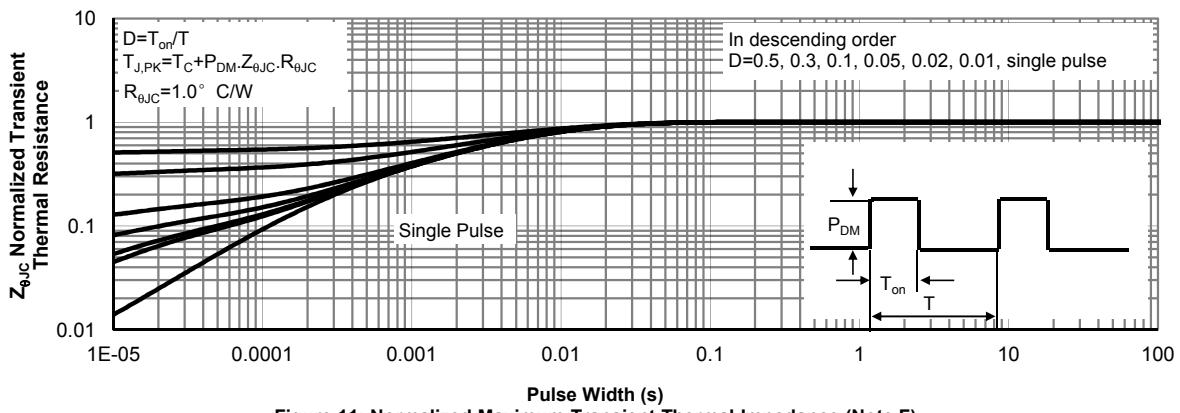


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

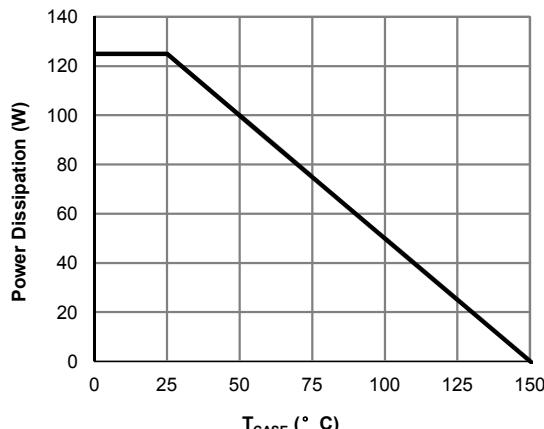
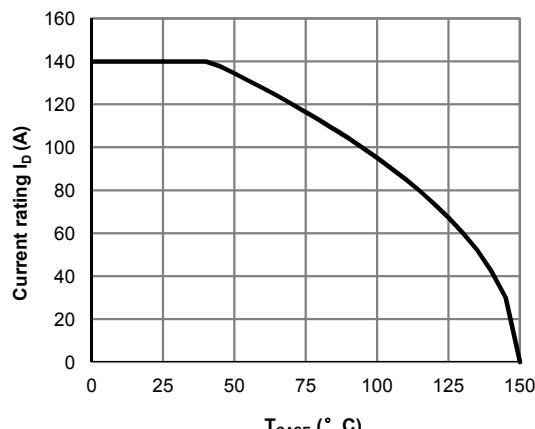
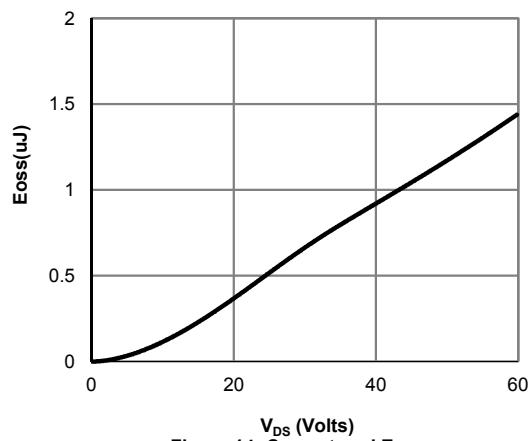
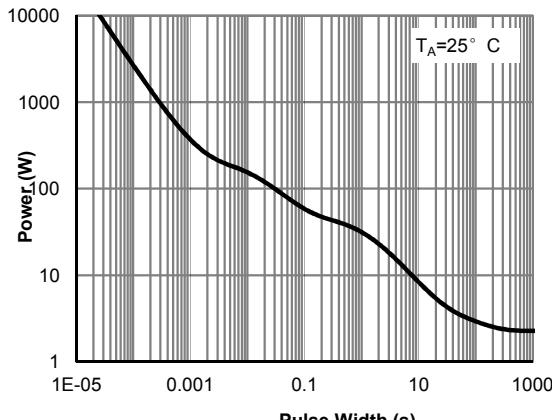
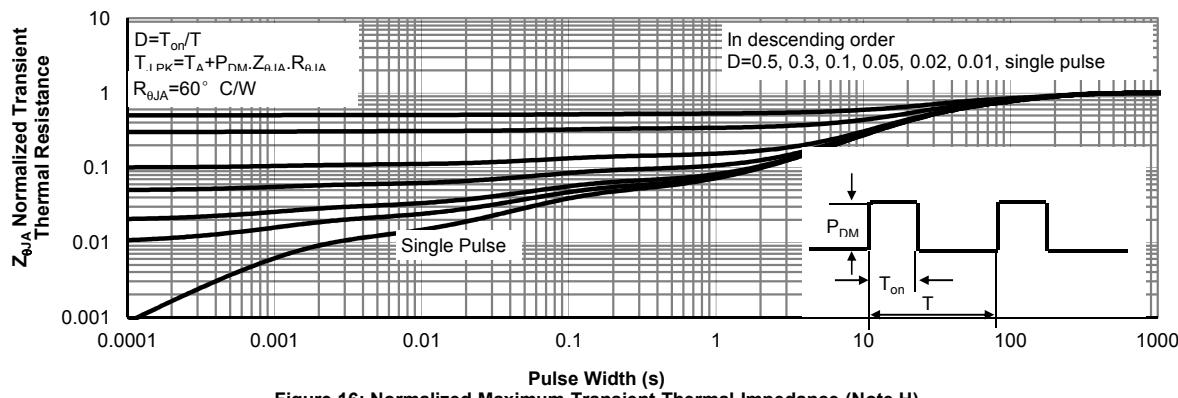
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Coss stored Energy

Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

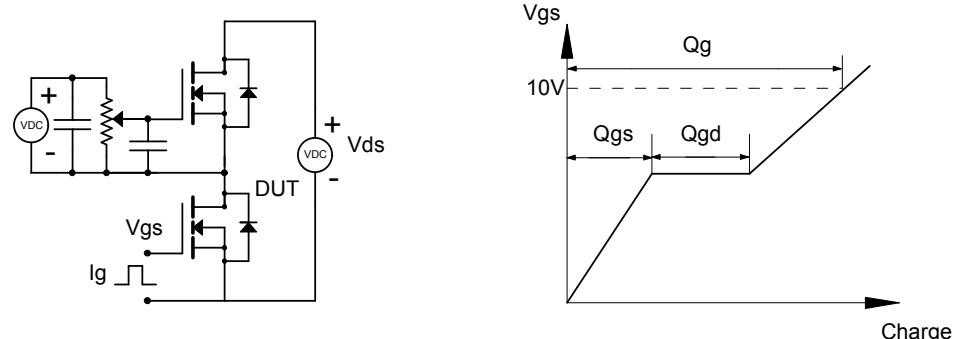


Figure B: Resistive Switching Test Circuit & Waveforms

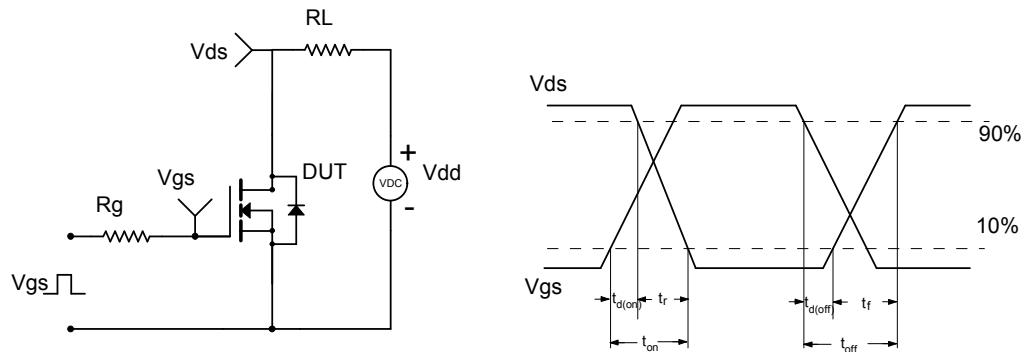


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

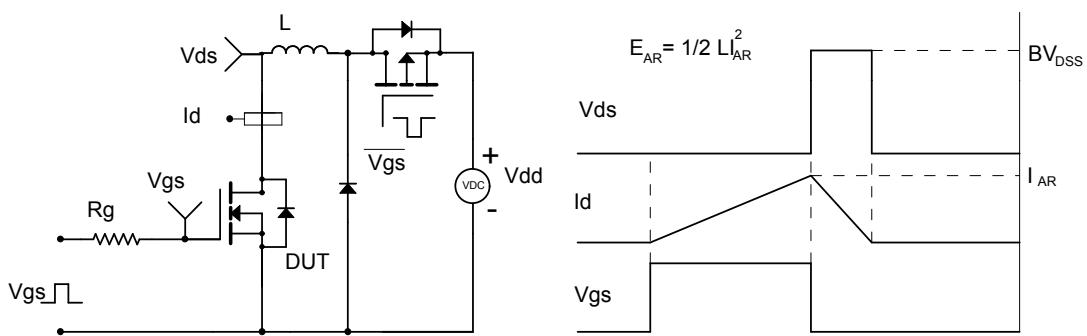


Figure D: Diode Recovery Test Circuit & Waveforms

